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CONFIRMATION NO. 8652

<b>SERIAL NUMBER</b> 10/531,434	<b>FILING OR 371(c) DATE</b> 02/17/2006 <b>RULE</b>	<b>CLASS</b> 117	<b>GROUP ART UNIT</b> 1722	<b>ATTORNEY DOCKET NO.</b> JG-SU-5213/500577.20067
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**APPLICANTS**

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**\*\* CONTINUING DATA \*\*\*\*\***

This application is a 371 of PCT/JP03/13320 10/17/2003

**\*\* FOREIGN APPLICATIONS \*\*\*\*\***

JAPAN 2002-304410 10/18/2002

**IF REQUIRED, FOREIGN FILING LICENSE GRANTED**

\*\* 03/15/2006

Foreign Priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no	<b>STATE OR COUNTRY</b> JAPAN	<b>SHEETS DRAWING</b> 18	<b>TOTAL CLAIMS</b> 14	<b>INDEPENDENT CLAIMS</b> 3
35 USC 119 (a-d) conditions met <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance				
Verified and Acknowledged <i>F.H.</i>	Examiner's Signature	Initials		

**ADDRESS**

26418

**TITLE**

Method for measuring point defect distribution of silicon single crystal ingot

<b>FILING FEE RECEIVED</b> 1030	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees
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